

**Search Notes**

Application/Control No.

10/674,426

Examiner

James D. Ewart

Applicant(s)/Patent under  
Reexamination

DIEDRICH ET AL.

Art Unit

2617

**SEARCHED**

Class	Subclass	Date	Examiner
455	41.1 79 90.1 414.1 414.3 552.1	1/4/2006	JDE
	556.1 557		
	566 569.1		
	575.9		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR